Announcing a Special Issue of the IEEE/Optica Publishing Group Journal of Lightwave Technology on:

GUIDED LIGHTWAVES FOR SENSORS & MEASUREMENT SYSTEMS: ADVANCED TECHNIQUES and APPLICATIONS

This special issue is organized by the IEEE Instrumentation and Measurement Society. It will be the fourth special issue on the same topic following the previous three successful ones (2017, 2019 and 2021). It aims to highlight the advancement of guided lightwaves in applications to sensors, instrumentation and measurement. The scope includes, but is not limited to the following:

Scope description:

- Sensors and instrumentation for industrial, environmental, biological and energy applications including
  - chemical, medical and biological applications
  - environmental monitoring
  - structural health monitoring
  - traditional and renewable energy monitoring
- Novel concepts and mechanisms of guided lightwaves for sensing and measurement
- Advanced materials, structures technologies of guided lightwaves for sensing and measurement
- Instrumentation for optical fiber communication monitoring applications
- Micro- and nano-scale sensors
- Multiplexing and distributed sensor networks
- High speed instrumentation and measurement systems
- Sensor fusion, big data and artificial intelligence

On behalf of the Guest Editors and the Editor-in-Chief, we encourage you to submit your work for inclusion in this Special Issue. Accepted papers will appear in the June/July 2023 hardcopy issue with accepted papers posted online within one week of author final file upload. Mandatory page charges of $260.00 per page are enforced for Original Contributions in excess of 7 pages and Invited Papers in excess of 10 pages. Tutorial presenters will be invited to write articles that are up to 16 pages in length. The same mandatory fees apply to each Tutorial paper in excess of 16 pages.

Submissions by website only: http://mc.manuscriptcentral.com/jlt-ieee
Manuscript Type: “IMS 2023”
Submission questions: Doug Hargis, Journal of Lightwave Technology d.hargis@ieee.org

The Guest Editors for this Special Issue are: Dr. Gaozhi (George) Xiao, National Research Council of Canada; Prof. Tuan Guo, AE of JLT, Jinan University, China; Prof. Fei Xu, AE of JLT, Nanjing University, China; Dr. Francesco Chiavaioli, Institute of Applied Physics "Nello Carrara", IFAC National Research Council of Italy

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